

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10696817	LE, HIEN K.
	Examiner	Art Unit
	Rampuria, Satish S	2191

SEARCHED

Class	Subclass	Date	Examiner
717	100-103	2/15/2007 (updated on 8/23/07)	SR (SR)
705	1,7,400	2/15/2007 (updated on 8/23/07)	SR (SR)

SEARCH NOTES

Search Notes	Date	Examiner
East (all database)	2/15/2007 (updated on 8/23/07)	SR (SR)
Inventor Name Search	2/15/2007	SR
NPL (IEEE)	2/15/2007	SR
Text Search	2/15/2007 (updated on 8/23/07)	SR (SR)
Plus Search	11/30/2006	SR
Wei Zhen, SPE (discussed the appeal brief)	6/10/2008	SR
Appeal Brief Conf. held with Satish Rampuria, Wei Zhen, and Eddie Lee	6/17/2008	SR

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner